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Resonant Energy Transfer in Si Nanocrystal Solids

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ABSTRACT: Energy exchange between closely packed semiconductor quantum dots allows for long-range transfer of electronic energy and enables new functionalities of nanostructured materials with a huge application potential in photonics, optoelectronics, and photovoltaics. This is illustrated by impressive advances of quantum-dot solids based on nanocrystals (NCs) of direct bandgap materials, where this effect has been firmly established. Regrettably, the (resonant) energy transfer in close-packed ensembles of NCs remains elusive for silicon—the main material for electronic and photovoltaic industries. This is the subject of the present study in which we conclusively demonstrate this process taking place in dense dispersions of Si NCs in a SiO2 matrix. Using samples with different NC configurations, we can directly determine the wavelength dependent energy transfer rate and show that it (i) can be modulated by material parameters, and (ii) decreases with the NCs size, and thus being consistent with the energy flow proceeding from smaller to larger NCs. This result opens the way to new applications of Si NCs, requiring energy transport and extraction. In particular, it forms a fundamental step toward development of an excitonic all-Si solar cell, operating in some analogy to polymer devices.

INTRODUCTION

Next to the external bias-driven tunneling of carriers,1−4 energy transfer (ET) between neighboring NCs based on the intrinsic electronic properties, often described in terms of the Förster mechanism,5 constitutes a necessary step for realization of the long-range energy transfer in an ensemble of closely packed NCs. In direct bandgap NCs, ET has been investigated in detail and conclusively demonstrated.6−9 In that research, two NC ensembles, with well-defined but distinctly different average sizes, have been prepared and optically characterized, and then mixed to form a densely packed quantum solid. It was found that upon mixing, the photoluminescence (PL) lifetime of the small NCs was shortened, whereas that of large NCs was extended. Taken together with an efficiency change of the respective PL bands, this result provided an unequivocal evidence of the energy transfer taking place from small to large NCs. Unfortunately, this successful strategy is not available for Si, where development of NCs with a sufficiently narrow size distribution is (still) not achieved. Moreover, theoretical evaluation based on a phonon-less tight-binding approach,10 predicted ET to be inefficient for Si NCs due to the indirect bandgap. Nevertheless, based on experimental findings, several reports postulated that ET does take place between proximal Si NCs.11−15 These findings included (i) stretched exponential character of (ensemble) PL decay,11,12,14 (ii) red-shift of PL spectra upon delay time,12,14 and (iii) size-dependent internal quantum efficiencies (IQEs).1,3,11 However, for all these observations also alternative explanations, not involving ET, could be given: The stretched-exponential character of PL decay can be explained by dispersion of lifetimes of NCs emitting at the same wavelength, which might easily appear, e.g., due to differences in surface passivation/termination or shape.16,17 Similarly, the red shift of PL spectra during decay will also appear as a consequence of lifetime shortening in small “blue” NCs due to enhanced confinement. Lastly, the size-dependent IQE of Si NCs, which increases for larger diameters, can equally well be explained by the generally better crystalline and surface qualities (lower curvature) of larger NCs.18 Therefore, while these experimental findings are consistent with the energy transfer within an ensemble of Si NCs, they do not provide a proof of its occurrence. The goal of this study is to conclusively resolve the important issue of ET between Si NCs. On the basis of the excitation intensity dependent time-resolved emission spectroscopy, we are able to demonstrate and directly quantify ET for an individual sample, enabling us to compare ET rates for Si NCs in different configurations.

Supporting Information

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For the purpose of this study, samples of closely packed Si NCs have been produced. The investigated structures are prepared by magnetron cosputtering, followed by a 30 min anneal in nitrogen atmosphere at 1250 °C. This method is well-known to yield high-quality Si NCs with relatively narrow (log-normal) size distributions with dispersions of below 20%. Two kinds of samples have been made, featuring two- and three-dimensional (2D and 3D) NC packing structures (arrays), as schematically illustrated in Figure 1(a)—for more details, see the Experimental Section. In the past, Halivni et al.19 showed that resonant energy transfer is influenced by the dimensionality of the process, and this we could expect in our structures as well. Due to the relatively large separation between 2D sheets of NCs, we expect no energy transfer between NC layers—see also the derivation of the average NC separation later on. As a result, reduction of the energy transfer rate (ΓET) should be observed—schematically illustrated as 2D ET confinement in Figure 1(a).

Figures 1(b) and 2(a) display transmission electron microscopy (TEM) and high-resolution TEM (HRTEM) images, respectively, of both structures. By TEM, the superlattice structure of the 2D arrays is confirmed, whereas a random positioning of Si NCs is observed for the 3D array. By HRTEM, the diamond structure of the Si NCs is conclusively established. In order to obtain sufficient statistics for the size determination, more than 100 NCs per sample have been analyzed; the resulting histograms are shown in Figure 2(b). We conclude on the smaller average size and also a narrower size distribution for the NCs in the 2D array when compared to the 3D packing. Having estimated the size distribution, we can calculate the average nearest-neighbor surface-to-surface distance, RNN, for both structures. By performing Monte Carlo simulations, we get an RNN of 3.9 and 2.2 nm for the 2D and 3D structures, respectively—see Supporting Information (SI) for details. While the exact value of the RNN is sensitive to methodology, the trend is firmly established, and the 2D structure indeed experiences a larger RNN intuitively justified by the presence of the passive layer. We note that, while the dipole–dipole driven ET does not involve photons and therefore is insensitive to the local density of states,20 the ΓET should be strongly influenced by RNN. Hence, both arguments—differences in size distributions and RNN values (based on HRTEM data)—strengthen the hypothesis that ET between Si NCs should be suppressed in the 2D structure.

After this microscopic characterization, spectral and temporal characteristics of PL of the structures could be investigated. Figure 3(a) and (b) presents time-resolved PL spectra for 3D and 2D NC packing, respectively. We observe for both samples a gradual red shift of the maximum of the PL spectrum upon decay—for clarity, the shifts of PL maxima are explicitly given in the insets. Temporal analysis reveals, for both configurations, PL decay times in the μs-regime, typical for high-quality Si NCs of these sizes prepared by cosputtering. In order to fit the PL transients depicted in Figure 3(c), the stretched exponential function \( e^{-(t/\tau)^\beta} \) was used21 (where \( t \) is the lifetime and \( \beta \) is the dispersion factor), with \( \beta \) values between 0.7 and 0.9, as commonly observed.11 As previously mentioned, both of these features—the temporal red shifting and the stretched exponential decay of PL—have been observed before and misinterpreted as proof of energy transfer within the ensemble of Si NCs.

In order to explicitly probe ET, we make use of PL quenching, which appears when energy is transferred to an already excited NC—see Figure 4(a). In that case, nonradiative recombination of the transferred exciton arises due to an efficient Auger interaction between multiple excitons localized within the same NC. Auger interactions in Si NCs have been investigated in the past22–24 and found to occur on a subnanosecond time-scale, which is beyond the resolution of the current experiment. In fact, the time-resolution of the...
experiment prohibits the detection of PL transients appearing due to any ultrafast nonlinear effect, whether it is the detection of Auger interactions or, for example, carrier multiplication. Nevertheless, ET toward an excited NC would lead to immediate excitation loss (due to Auger interactions), causing PL intensity loss on the time-scale of ET. Since the number of initially excited NCs will increase with the excitation photon flux, ET will introduce a very characteristic, additional nonradiative recombination path whose rate will increase with the excitation power. In saturation, when all NCs are excited, a single ET event results in exciton quenching and in that way the ET rate in the investigated material (Γ_{ET}), can be directly measured. However, if ET would not occur, as frequently suggested in the past, the effective PL decay time should be independent of the excitation power. Figure 4(b) schematically illustrates the idea of the experiment: the presence of ET between NCs manifests itself as a gradual decrease of the effective PL lifetime as the pump laser power is increased to the point where all NCs are excited, i.e., the PL saturation is reached. At this point, an equilibrium situation is obtained between the excitation and de-excitation rates, the latter comprising the radiative recombination and the nonradiative quenching by energy transfer to the nearest neighbor. Further increase of the excitation power results in the generation of multiple excitons per NC, which leads to their immediate quenching by Auger interaction, and therefore not altering the PL lifetime.

It is important to note that upon increase of the excitation power, besides an ET-induced effect, a lifetime change will also appear due to earlier saturation of PL from larger NCs. This originates from the fact that while PL is detected within a narrow slit-determined wavelength range (around 1 nm), this line width has to be convoluted with the broad emission (120 meV at 300 K) of a single NC of a particular size. However, when taking into account the size dependent absorption cross sections in combination with the expected variation of NC sizes within our narrow wavelength range, the change of effective lifetime, as a result of the saturation effect, remains within the experimental accuracy of the lifetime determination (see the SI for a detailed evaluation). Therefore, we are able to determine the absolute value of wavelength-dependent Γ_{ET}.
based solely on the measurements on a single sample, after which it is possible to compare the values, for different samples.

Figures 5(a) and (b) show the experimental results for 3D and 2D packing structures, for an emission wavelength of 950 nm (corresponding to a NC diameter of around 5 nm)—the data of other emission wavelengths are depicted in the SI. Since we are interested in probabilities of exciting neighboring NCs, we express—on the x-axis—the excitation power as the average number of absorbed photons per NC ($N_{\text{abs}}$). In this way, we end up with a fair comparison of the excitation regime for 2D and 3D samples. Saturation of PL intensity$^{25}$ is used to deduce the proper $N_{\text{abs}}$ regime—see SI for details. We point out on the rather high $N_{\text{abs}}$ values, which are a result of the strong attenuation of the excitation beam throughout the sample, hereby causing a big excitation-regime difference between the front and the back surface of the samples. We clearly see that, for both materials, the PL decay time decreases with excitation power, reaching a stable value as PL intensity saturates, i.e., when all the NCs in the ensemble have been excited. The increase of PL intensity is accompanied by a shortening of the effective PL decay time, which approaches a constant value as PL saturation is reached. We note that the concurrent change of the lifetime and PL intensity clearly links the lifetime shortening to excitation of NCs, ruling out other possible explanations of the effect in terms of, e.g., energy transfer to defect states. Therefore, the present result provides direct evidence for the presence of ET between neighboring NCs.

With the experimental results depicted in Figure 5(a) and (b), we can evaluate the transfer rate ($\Gamma_{\text{ET}}$) by subtracting the radiative recombination rate ($\Gamma_{\text{rad}}$) from the experimentally measured effective recombination rate ($\Gamma_{\text{eff}}$)—a reasonable estimation based on the fact that other nonradiative recombination paths, such as defect states, quench PL on a submicrosecond time-scale and are therefore not probed in our experimental setup. The relevant $\Gamma_{\text{rad}}$ is calculated using data from ref 13 corrected for the host parameters of our materials—see SI for details of the calculation procedure. The results are depicted in Figure 6. In the saturation regime, this nonradiative contribution represents the rate of a single ET event, and in that way, we can determine the characteristic ET time constant, for the 3D and 2D NC structures as 0.9 and 3.3 ms, respectively. Hence, in line with the previously discussed expectation, we conclude that the $\Gamma_{\text{ET}}$ is indeed reduced for the 2D structure. In Figure 7, we depict the experimentally determined wavelength dependence of the $\Gamma_{\text{ET}}$, a gradual increase toward shorter wavelength is observed, indicating a more efficient transfer process for smaller NCs. This is fully consistent with the proposed interpretation of the lifetime reduction in terms of ET, which is more probable for small NCs, as these are more likely to have a larger neighbor available for the ET. In terms of the physical mechanism, we postulate that ET in our systems should be explained in the framework of a phonon-assisted resonant ET process,$^{29}$ whose efficiency is considerably higher than that of the phonon-less process. We recall that eventual electron/hole transfer between NCs, frequently discussed in the literature,$^{30,31}$ is limited to NCs in direct contact with each other and takes place on a picosecond
monochromator (HORIBA Jobin Yvon) coupled to a Hamamatsu photo multiplier tube. Excitation wavelengths of 520 and 355 nm were used to cover a broad range of excitation power regimes. Absorption measurements were carried out using a UV–vis Lambda900 spectrometer in combination with an integrating sphere, accounting for reflection and scattering effects. All spectra were corrected for the system response.

## ASSOCIATED CONTENT

### Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acs.jpcc.5b06339.

1. A calculation of the radiative recombination rate. (2) Elaborate explanation on the attenuation of the excitation beam through the sample. (3) Monte Carlo simulations to estimate the average nearest-neighbor surface-to-surface distance. (4) Additional power-dependent effective lifetimes. (5) A detailed discussion on the effect of partial saturation. (PDF) (ZIP)

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